

N-Channel Enhancement Mode MOSFET

TDM3578

**DESCRIPTION**

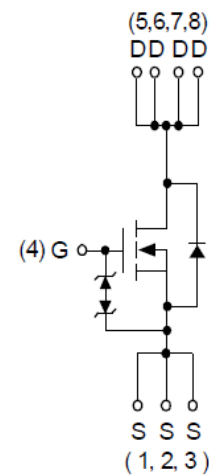
The TDM3578 uses advanced trench technology to provide excellent RDS(ON) and low gate charge. This device is suitable for use as a load switch or in PWM applications.

**GENERAL FEATURES**

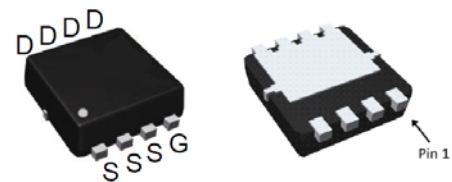
- RDS(ON) <6.7mΩ @ VGS=10V  
RDS(ON) < 10.3mΩ @ VGS=4.5V
- High Power and current handling capability
- Lead free product is available
- Surface Mount Package

**Application**

- PWM applications
- Load switch
- Power management



N-Channel MOSFET



PPAK-3\*3-8

ABSOLUTE MAXIMUM RATINGS(T<sub>A</sub>=25°C unless otherwise noted)

Parameter	Symbol	Limit	Unit
Drain-Source Voltage	V <sub>DS</sub>	40	V
Gate-Source Voltage	V <sub>GS</sub>	±20	V
Diode Continuous Forward Current	I <sub>S</sub> (T <sub>C</sub> =25°C)	20	A
Drain Current @ Continuous	I <sub>D</sub> (T <sub>C</sub> =25°C)	61	A
	I <sub>D</sub> (T <sub>C</sub> =100°C)	43	A
Drain Current @ Current-Pulsed	I <sub>DM</sub> (T <sub>C</sub> =25°C)	244	A
Maximum Power Dissipation (T <sub>C</sub> =25°C)	P <sub>D</sub> (T <sub>C</sub> =25°C)	50	W
	P <sub>D</sub> (T <sub>C</sub> =100°C)	23.5	W
Drain Current @ Continuous(Note a)	I <sub>D</sub> (T <sub>A</sub> =25°C)	14.2	A
	I <sub>D</sub> (T <sub>A</sub> =70°C)	12	A
Drain Current @ Current-Pulsed (Note b)	I <sub>DM</sub> (T <sub>A</sub> =25°C)	57	A
Maximum Power Dissipation(Note a)	P <sub>D</sub> (T <sub>A</sub> =25°C)	2.5	W
	P <sub>D</sub> (T <sub>A</sub> =70°C)	1.8	W
Maximum Operating Junction Temperature	T <sub>J</sub>	175	°C
Storage Temperature Range	T <sub>STG</sub>	-55 To 175	°C
Thermal Resistance,Junction-to-Case	R <sub>θJC</sub>	4.5	°C/W
Thermal Resistance,Junction-to-Ambient (Note a)	R <sub>θJA</sub>	60	°C/W

**N-Channel Enhancement Mode MOSFET**
**TDM3578**
**ELECTRICAL CHARACTERISTICS** ( $T_A=25^{\circ}\text{C}$  unless otherwise noted)

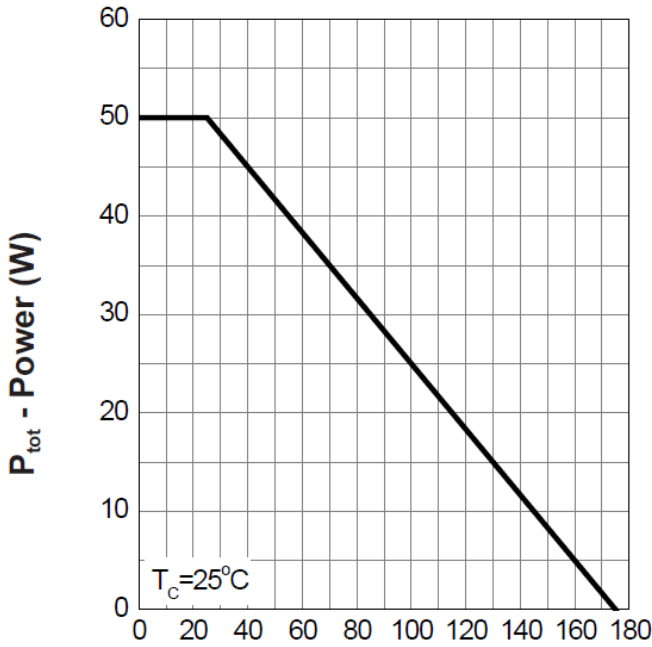
Parameter	Symbol	Condition	Min	Typ	Max	Unit
<b>Static Characteristics</b>						
Drain-Source Breakdown Voltage	$BV_{DSS}$	$V_{GS}=0V, I_D=250\mu A$	40	-	-	V
Zero Gate Voltage Drain Current	$I_{DSS}$	$V_{DS}=32V, V_{GS}=0V$	-	-	1	$\mu A$
Gate-Body Leakage Current	$I_{GSS}$	$V_{GS}=\pm 20V, V_{DS}=0V$	-	-	$\pm 10$	$\mu A$
Gate Threshold Voltage	$V_{GS(th)}$	$V_{DS}=V_{GS}, I_D=250\mu A$	1.4	1.7	2.5	V
Drain-Source On-State Resistance <sup>(Note d)</sup>	$R_{DS(ON)}$	$V_{GS}=10V, I_D=20A$	-	5.6	6.7	m $\Omega$
		$V_{GS}=4.5V, I_D=15A$	-	7.9	10.3	m $\Omega$
<b>DYNAMIC CHARACTERISTICS</b>						
Gate Resistance	$R_G$	$V_{GS}=0V, V_{DS}=0V, F=1MHz$	-	1.5	-	$\Omega$
Input Capacitance	$C_{iss}$	$V_{DS}=20V, V_{GS}=0V, F=1.0MHz$	-	911	1185	PF
Output Capacitance	$C_{oss}$		-	222	-	PF
Reverse Transfer Capacitance	$C_{rss}$		-	30	-	PF
Turn-on Delay Time	$t_{d(on)}$	$V_{DS}=20V, R_L=20\Omega, V_{GEN}=10V, R_G=6\Omega$ $I_{DS}=1A$	-	11.3	21-	nS
Turn-on Rise Time	$t_r$		-	8.2	15	nS
Turn-Off Delay Time	$t_{d(off)}$		-	22.6	41	nS
Turn-Off Fall Time	$t_f$		-	15.4	28	nS
<b>Gate Charge Characteristics<sup>(Note e)</sup></b>						
Total Gate Charge	$Q_g$	$V_{DS}=20V, I_D=20A, V_{GS}=10V$	-	15	21	nC
Total Gate Charge	$Q_g$	$V_{DS}=20V, I_D=20A, V_{GS}=4.5V$	-	7.1	-	nC
Gate-Source Charge	$Q_{gs}$		-	3.2	-	nC
Gate-Drain Charge	$Q_{gd}$		-	1.9	-	nC
<b>Diode Characteristics</b>						
Body Diode Reverse Recovery Time	$T_{rr}$	$I_{DS}=20A, di/dt=100A/\mu s$	-	18.3	-	nS
Body Diode Reverse Recovery Charge	$Q_{rr}$		-	6.4	-	nC
Diode Forward Voltage <sup>(Note d)</sup>	$V_{SD}$	$V_{GS}=0V, I_S=20A$	-	0.8	1.1	V

**NOTES:**

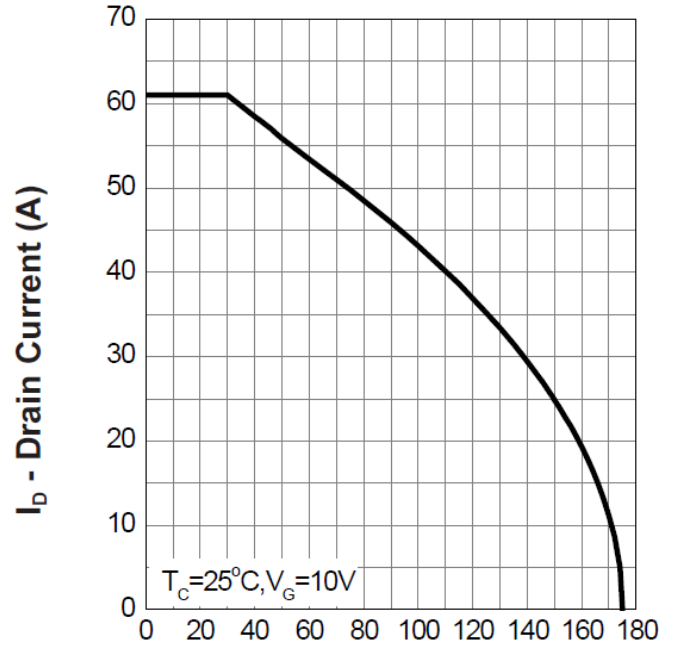
- Surface mounted on  $1in^2$  pad area, steady state  $t = 999s$ .
- Pulse width limited by max. junction temperature..
- UIS tested and pulse width limited by maximum junction temperature  $175^{\circ}\text{C}$  (initial temperature  $T_J=25^{\circ}\text{C}$ ).
- Pulse test ; pulse width  $\leq 300ms$ , duty cycle  $\leq 2\%$ .
- Guaranteed by design, not subject to production testing

Typical Operating Characteristics

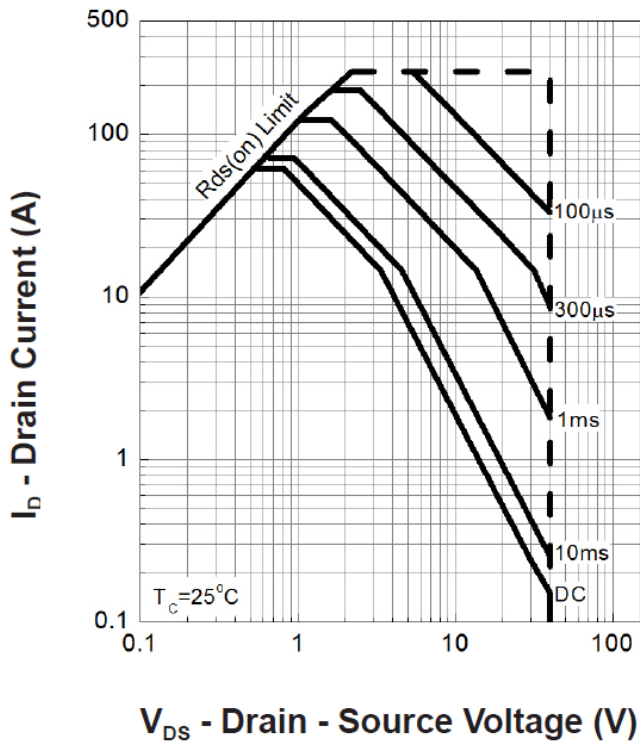
Power Dissipation



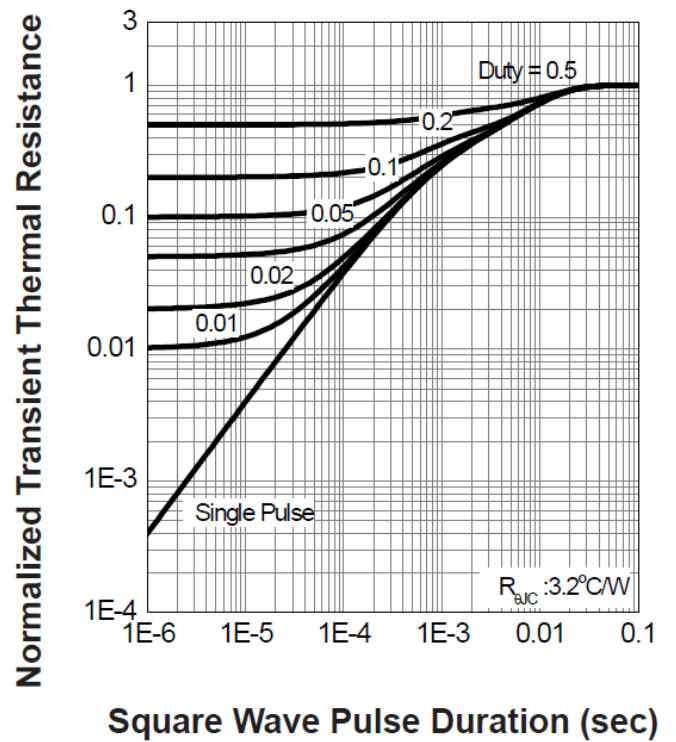
Drain Current



T<sub>j</sub> - Junction Temperature (°C)  
Safe Operation Area

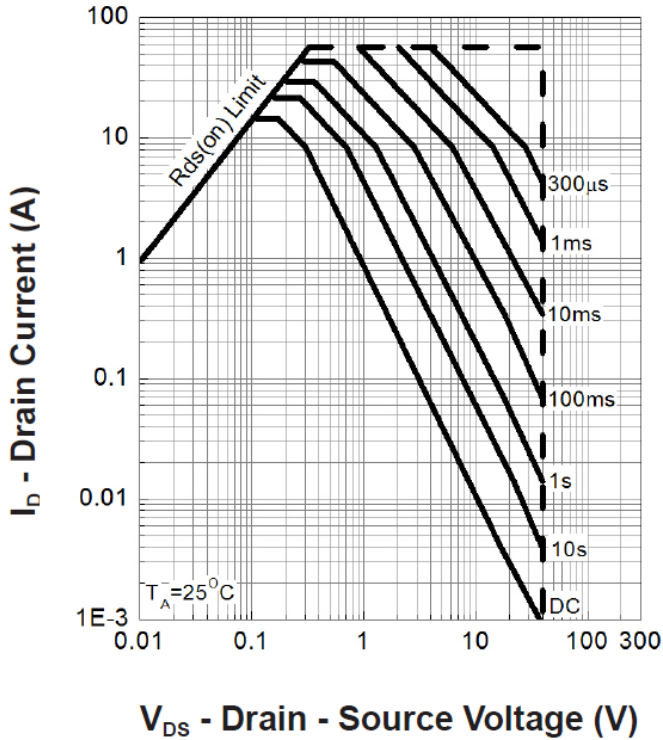


T<sub>j</sub> - Junction Temperature (°C)  
Thermal Transient Impedance

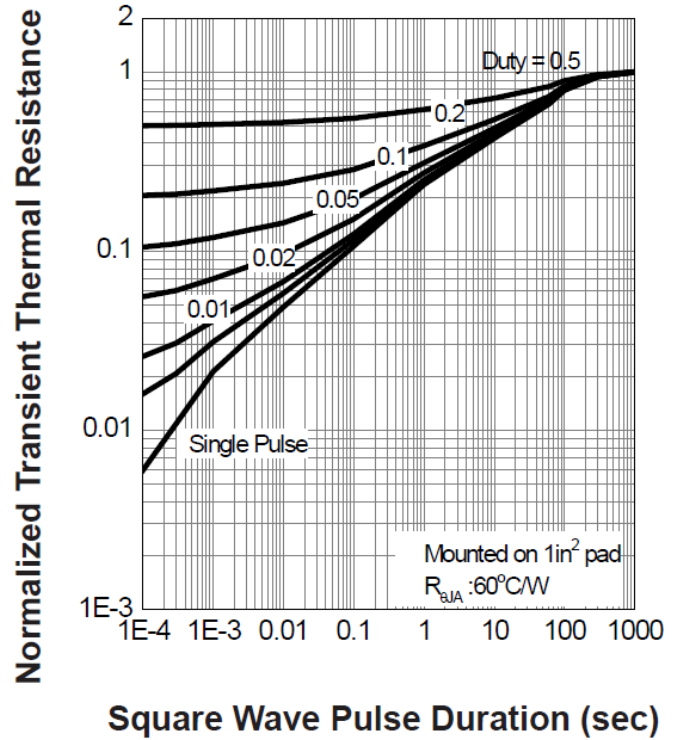


Typical Operating Characteristics(Cont.)

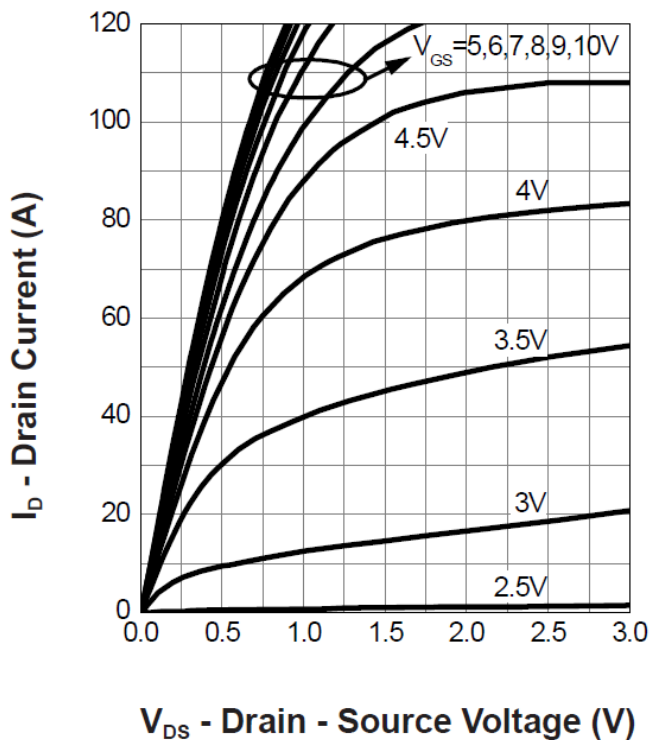
Safe Operation Area



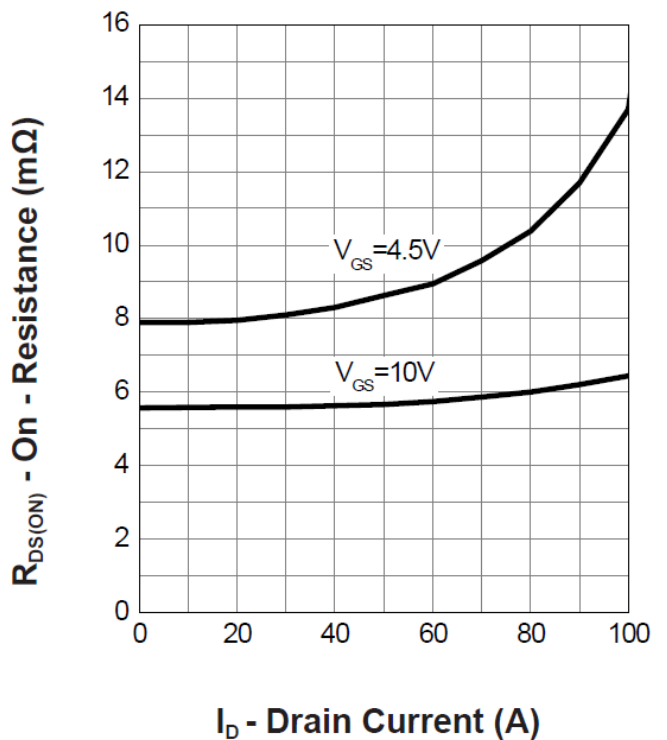
Thermal Transient Impedance



Output Characteristics

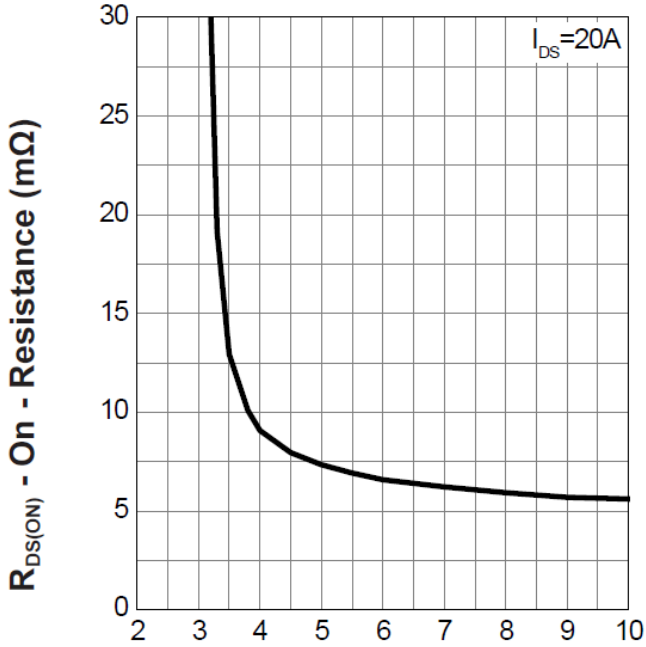


Drain-Source On Resistance



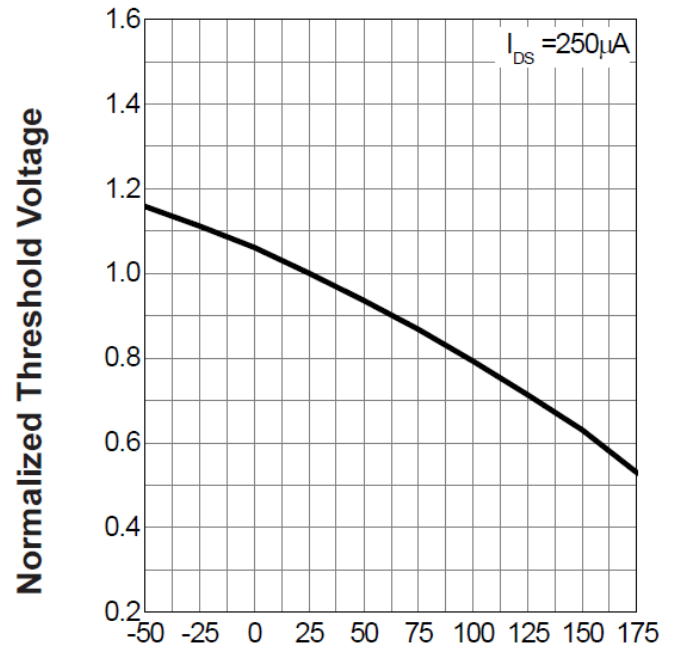
Typical Operating Characteristics (Cont.)

Gate-Source On Resistance



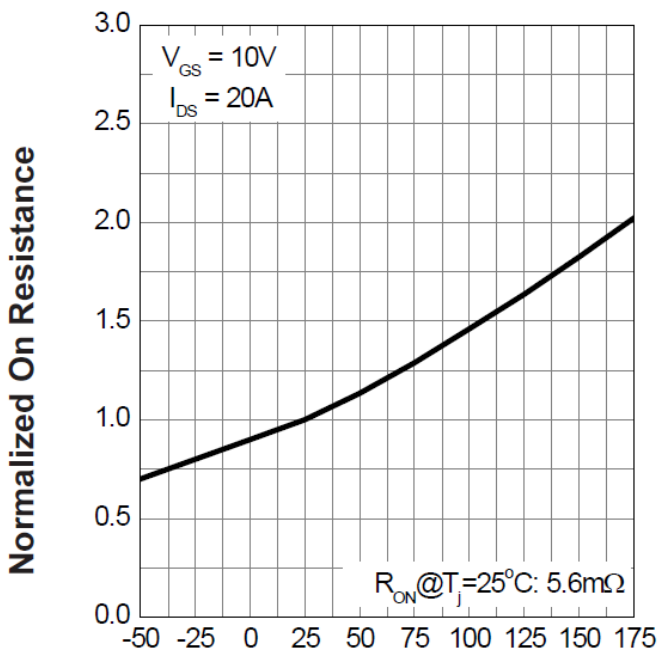
V<sub>GS</sub> - Gate - Source Voltage (V)

Gate Threshold Voltage



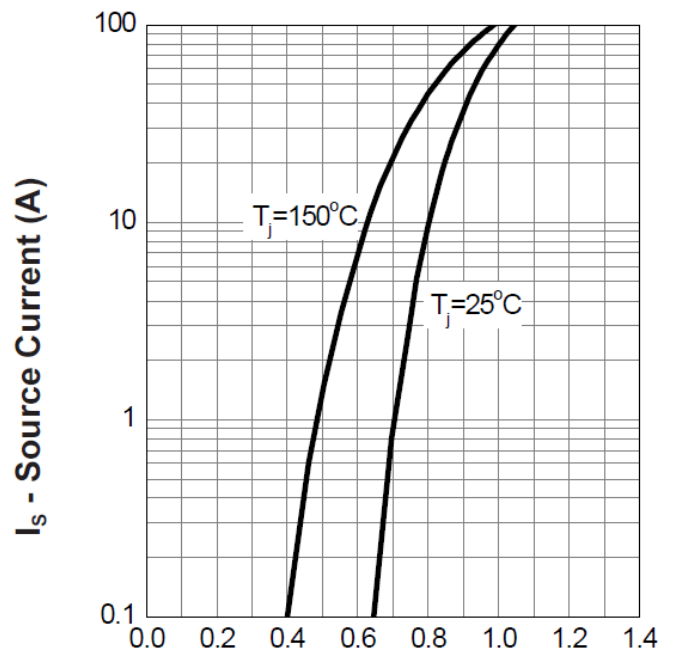
T<sub>J</sub> - Junction Temperature (°C)

Drain-Source On Resistance



T<sub>J</sub> - Junction Temperature (°C)

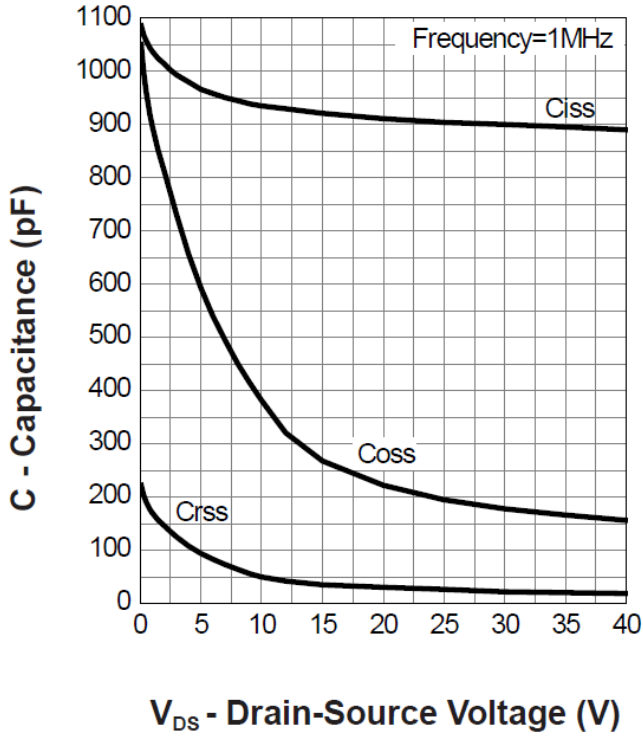
Source-Drain Diode Forward



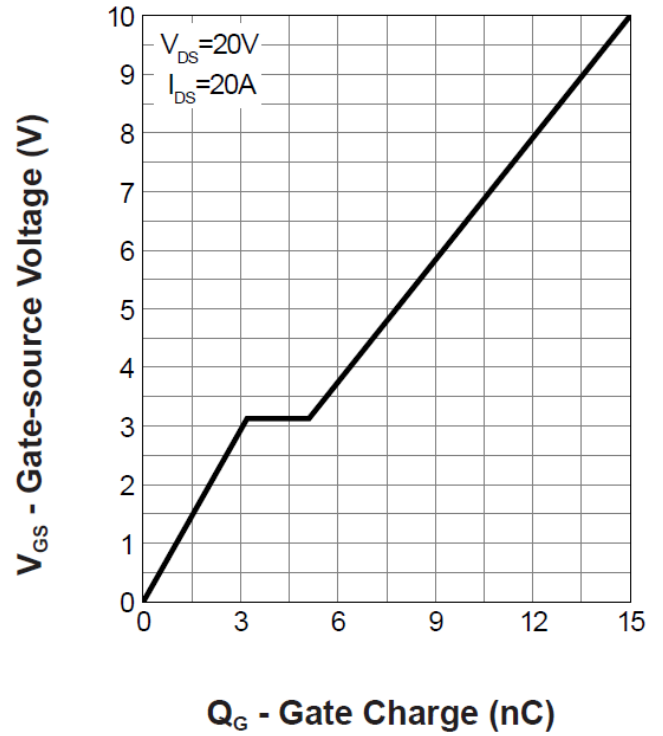
V<sub>SD</sub> - Source - Drain Voltage (V)

Typical Operating Characteristics (Cont.)

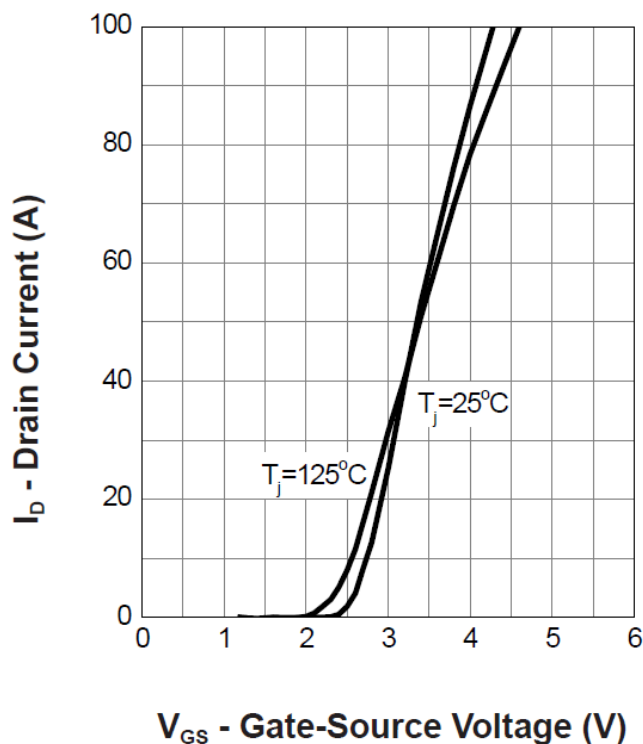
Capacitance



Gate Charge

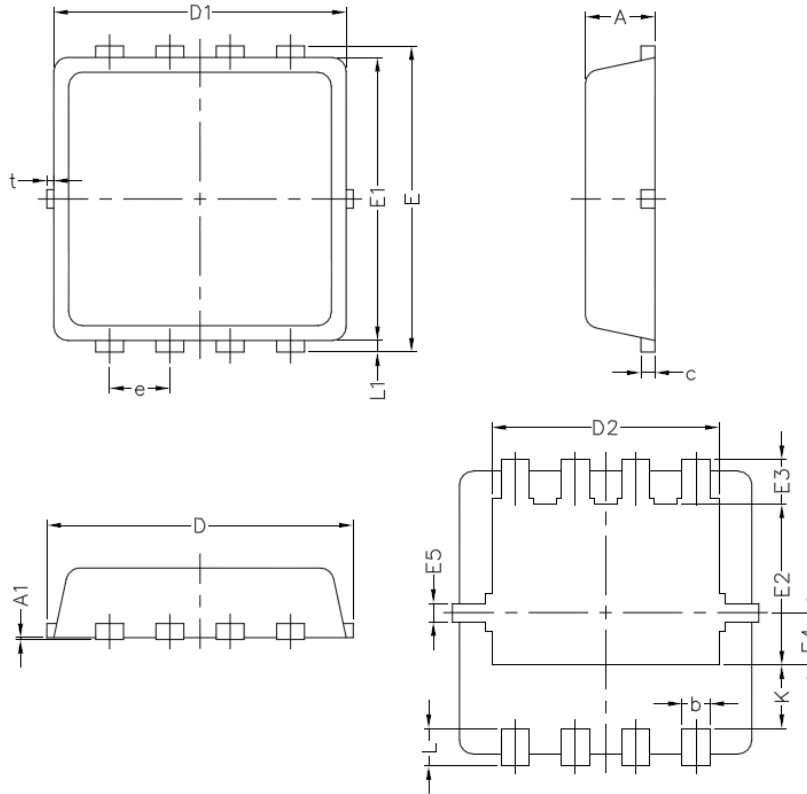


Transfer Characteristics



Package Information

PPAK-3\*3-8 Package



Symbol	PPAK-3*3-8(mm)		
	Min	Nom	Max
A	0.70	0.75	0.85
A1	/	/	0.05
b	0.20	0.30	0.40
c	0.10	0.152	0.25
D	3.15	3.3	3.45
D1	3.00	3.15	3.30
D2	2.25	2.45	2.65
E	3.15	3.30	3.45
E1	2.90	3.05	3.20
E2	1.54	1.74	1.94
E3	0.28	0.48	0.68
E4	0.37	0.57	0.77
E5	0.10	0.20	0.30
e	0.60	0.65	0.70
K	0.49	0.69	0.89
L	0.30	0.40	0.50
L1	0.06	0.125	0.20
t	/	/	0.13

Design Notes